

General Description

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low RDS(on) and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

Features

- Advanced high cell density Trench technology
 - Fast switching speed
 - Lower On-resistance
 - 100% EAS Guaranteed
 - Simple Drive Requirement

Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|----------------------|--------------------------------------|------------|-------|
| V_{DS} | Drain-Source Voltage | -30 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D@T_C=25^\circ C$ | Continuous Drain Current | -50 | A |
| I_{DM} | Pulsed Drain Current ¹ | -150 | A |
| EAS | Single Pulse Avalanche Energy | 115 | mJ |
| I_{AS} | Single Pulse Avalanche Current | -50 | A |
| $P_D@T_C=25^\circ C$ | Total Power Dissipation | 60 | W |
| T_{STG} | Storage Temperature Range | -55 to 175 | °C |
| T_J | Operating Junction Temperature Range | -55 to 175 | °C |

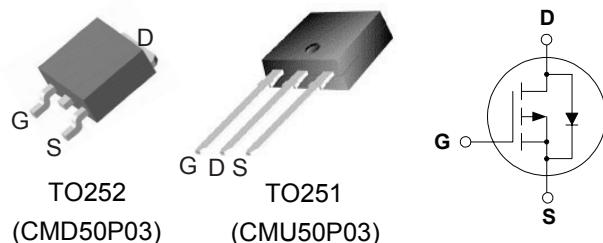
Product Summary

| BVDSS | RDS _{ON} | ID |
|-------|-------------------|------|
| -30V | 8mΩ | -50A |

Applications

- DC-DC Converters
 - Desktop PCs
 - LED controller

TO252 / TO251 Pin Configuration



Thermal Data

| Symbol | Parameter | Typ. | Max. | Unit |
|-----------------|----------------------------------|------|------|------|
| $R_{\theta JA}$ | Junction-to-Ambient ² | --- | 50 | °C/W |
| $R_{\theta JC}$ | Junction-to-Case (Drain) | --- | 1.1 | °C/W |

Electrical Characteristics ($T_J=25\text{ }^\circ\text{C}$, unless otherwise noted)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|---------------------|--|---|------|------|-----------|------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0\text{V}$, $I_D=-250\mu\text{A}$ | -30 | --- | --- | V |
| $R_{DS(\text{ON})}$ | Static Drain-Source On-Resistance ¹ | $V_{GS}=-10\text{V}$, $I_D=-20\text{A}$ | --- | --- | 8 | $\text{m}\Omega$ |
| | | $V_{GS}=-4.5\text{V}$, $I_D=-15\text{A}$ | --- | --- | 12 | |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}$, $I_D=-250\mu\text{A}$ | -1 | --- | -3 | V |
| I_{DSS} | Drain-Source Leakage Current | $V_{DS}=-30\text{V}$, $V_{GS}=0\text{V}$, $T_J=25\text{ }^\circ\text{C}$ | --- | --- | -1 | uA |
| | | $V_{DS}=-30\text{V}$, $V_{GS}=0\text{V}$, $T_J=125\text{ }^\circ\text{C}$ | --- | --- | -50 | |
| I_{GSS} | Gate-Source Leakage Current | $V_{GS}=\pm 20\text{V}$, $V_{DS}=0\text{V}$ | --- | --- | ± 100 | nA |
| g_{fs} | Forward Transconductance | $V_{DS}=-15\text{V}$, $I_D=-20\text{A}$ | --- | 52 | --- | S |
| Q_g | Total Gate Charge | $V_{DS}=-24\text{V}$, $I_D=-50\text{A}$ | --- | 45 | --- | nC |
| Q_{gs} | Gate-Source Charge | $V_{GS}=0$ to -10V | --- | 6.5 | --- | |
| Q_{gd} | Gate-Drain Charge | | --- | 10 | --- | |
| $T_{d(on)}$ | Turn-On Delay Time | | --- | 11 | --- | ns |
| T_r | Rise Time | $V_{DD}=-15\text{V}$, $V_{GS}=-10\text{V}$, $R_G=3.5\Omega$ | --- | 9 | --- | |
| $T_{d(off)}$ | Turn-Off Delay Time | $I_D=-50\text{A}$ | --- | 54 | --- | |
| T_f | Fall Time | | --- | 20 | --- | |
| C_{iss} | Input Capacitance | | --- | 3900 | --- | pF |
| C_{oss} | Output Capacitance | $V_{DS}=-25\text{V}$, $V_{GS}=0\text{V}$, $f=1\text{MHz}$ | --- | 750 | --- | |
| C_{rss} | Reverse Transfer Capacitance | | --- | 500 | --- | |

Diode Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------|------------------------------------|--|------|------|------|------|
| I_s | Continuous Source Current | $V_G=V_D=0\text{V}$, Force Current | --- | --- | -50 | A |
| I_{SM} | Pulsed Source Current ¹ | | --- | --- | -150 | A |
| V_{SD} | Diode Forward Voltage | $V_{GS}=0\text{V}$, $I_F=-30\text{A}$ | --- | --- | -1.5 | V |

Notes

1. Pulse test; pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
2. When mounted on 1" square PCB (FR-4 material).